Search Notes

_	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10559864	HAIK-BERAUD ET AL.
	Examiner	Art Unit
	Nacc-Ven M Nauven	1703

SEARCHED			
Class	Subclass	Date	Examiner
423	235,239.1, 248, 245.3, 245.1, 210, 220, 228, 230	3/29/09	NN

SEARCH NOTES		
Search Notes	Date	Examiner
East search	3/29/09	NN
Inventor name search	3/29/09	NN
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INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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